




<b>S arch d</b> 	Application/Control No. 10606925	Applicant(s)/Patent Under Reexamination KIM ET AL.
	Examiner Sherman, Stephen G	Art Unit 2629

Class	SubClass	Date	Examiner
345	76-80,204	8/18/2006	SS
315	169.3	8/18/2006	SS

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Notes	Date	Examiner
See attached search history		
Search Updated	8/18/2006	SS
NPL Documents Searched (ACM, INSPEC, IEEE)	8/18/2006	SS
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